

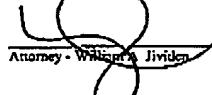
OFFICIAL**OFFICIAL****OFFICIAL**

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Application of

Applicants : Chandra V. Mouli and Ceredig Roberts
 Serial No. : 09/648,044
 Filed : August 25, 2000
 Confrm. No. : 6800
 Title : **METHOD AND DEVICE TO REDUCE GATE-INDUCED DRAIN LEAKAGE (GIDL) CURRENT IN THIN GATE OXIDE MOSFETs**
 Docket No. : MIO 0054 PA
 Examiner : O. Nadav
 Art Unit : 2811

CERTIFICATE OF FACSIMILE TRANSMISSION
 I hereby certify that this paper is being facsimile transmitted to the Patent and Trademark
 Office (File-No. 94-273-4300) on August 3, 2006


 Attorney - William J. Jividen Reg. No. 42,695

MAIL STOP RCE
 Commissioner for Patents
 P.O. Box 1450
 Alexandria, VA 22313-1450

Sir:

AMENDMENT WITH A REQUEST FOR CONTINUED EXAMINATION

This paper is being filed in response to the Final Office Action mailed May 3, 2006, and the Advisory Action mailed July 20, 2006, along with a request for continued examination. Reconsideration and reexamination are respectfully requested in light of the amendments and remarks below.